

## **SPECIFICATION FOR APPROVAL**

CUSTOMER	:						
CUSTOMER'S P/N	:						
PART NUMBER	: <u>WAN8010F2</u>	45H05					
DESCRIPTION	: Chip Antenna 8	010 M-Ant 2.4~2.	5G Type H05	\ <del>\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\</del>			
VERSION	: <u>V1.3</u>		St	. <b>V</b>			
ISSUE DATE	: <u>2023/08/01</u>		~ ( ) ( ) ( ) ( ) ( ) ( ) ( ) ( ) ( ) (				
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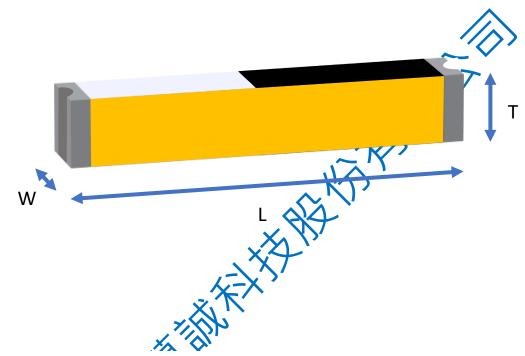
## OneWave Electronic Co., Ltd.

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# 8010 Chip antenna

## For Bluetooth / WLAN Applications



P/N: WAN8010F245H05

4		
1.0		Dimension (mm)
	L	8.01 ± 0.20
	W	1.03 ± 0.20
	T	1.25 ± 0.20



#### **Part Number Information**

WAN 8010 F 245 H 05
A B C D E F

Α	Product Series	Antenna
В	Dimension L x W	8.0X1.0mm (+-0.2mm)
С	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	Monopole & Single Feeding
F	Antenna type	Type = 05

## 1. Electrical Specification

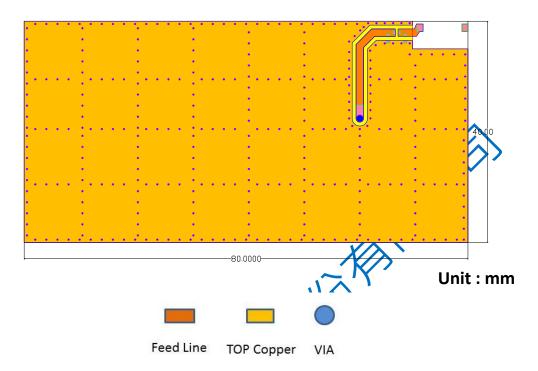
Specification							
Part Number	WAN8010F245H05						
Central Frequency	2450	MHz					
Bandwidth	100 (Min.)	MHz					
Return Loss	-10 (Max)	dB					
Peak Gain	3.53	dBi					
Impedance	50	Ohm					
Operating Temperature	-40~+110	°C					
Maximum Power	4	W					
Resistance to Soldering Heats	10 ( @ 260°C )	sec.					
Polarization	Linear						
Azimuth Beamwidth	Omni-directional						
Termination	Cu / Sn (Leadless)						

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



#### 2. Recommended PCB Pattern

#### **Evaluation Board Dimension**

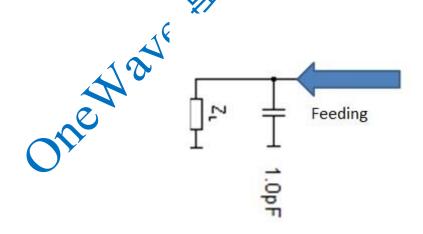


### Suggested Matching Circuit

**Important information:** 

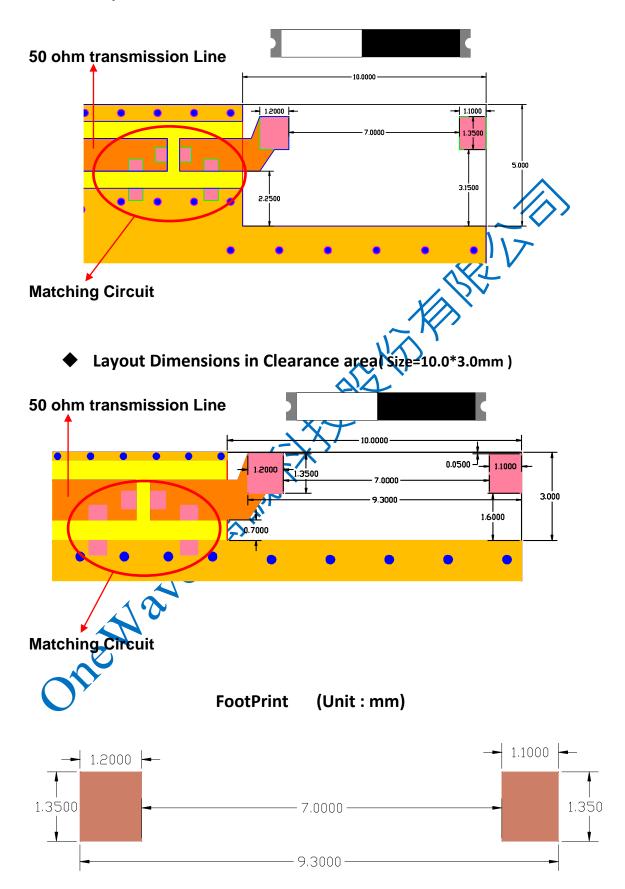
It is recommended to use highly accurate inductors

±0.1~0.3nH and capacitance ±0.1pF for matching components.





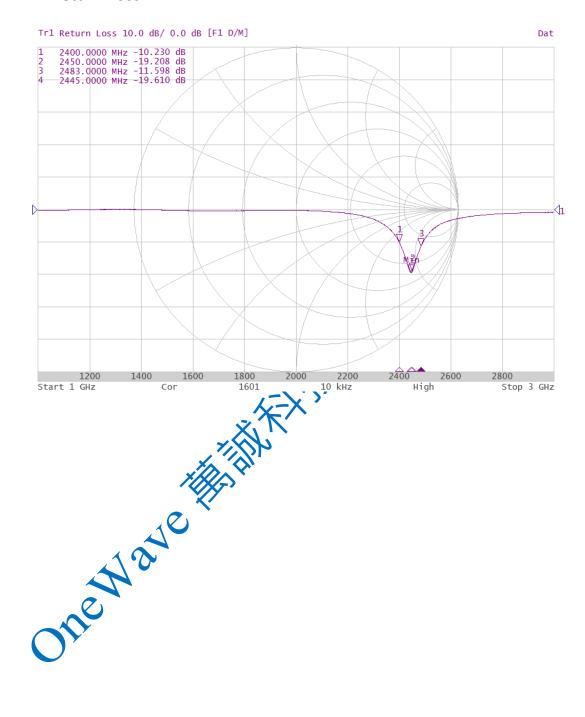
**♦** Layout Dimensions in Clearance area( Size=10.0\*5.0mm )





#### 3. Measurement Results

#### **Return Loss**





## **Radiation Pattern** Z -2 -10 -12 -14 2400 MHz 2450 MHz 2500 MHz 2400 MHz 2450 MHz 2500 MHz Power (dBm) Max: 3 Min: -15 Scale: 3/div XZ Max: 5 Min: -15 Scale: 3/div XY Max: 3 Min: -15 Scale: 3/div $\mathbf{YZ}$ Directivity Peak Gain 2400MHz 3.41 dBi 5.42 dBi 2450MHz 75.82 % 5.38 dBi 3.53 dBi 2500MHz 68.55 % 3.26 dBi 5.17 dBi **Chamber Coordinate System** SGH Turning Support



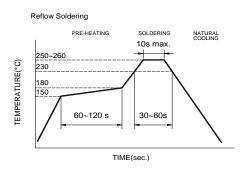
## **4.Reliability and Test Condictions**

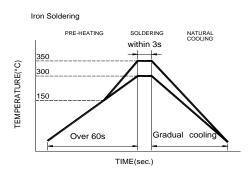
ITEM	REQUIREMENTS	TEST CONDITION			
Solderability	Wetting shall exceed 90% coverage	Pre-heating temperature:150°C /60sec.			
	2. No visible mechanical damage	Solder temperature:230±5°C			
	TEMP (℃)	Duration:4±1sec.			
	230°C 4±1 sec.	Solder:Sn-Ag3.0-Cu0.5			
	250 ( 421 500.	Flux for lead free: rosin			
	/ \				
	150°C				
	60sec				
	> oosec \				
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C /60sec.			
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C			
	TEMP (%)	Duration:10±0.5sec.			
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5			
	260°C 10±0.5 sec.	Flux for lead free: rosin			
		That for feat free. Tability			
	150℃	$\wedge$			
		N.T.			
	60sec \	150			
Component	No visible mechanical damage	The device should be reflow			
Adhesion		soldered(230±5°C for 10sec.) to a tinned			
(Push test)	1	copper substrate A dynometer force			
	<b>∼</b>	gauge should be applied the side of the			
		component. The device must with-ST-F			
		0.5 Kg without failure of the termination			
	A Navialla mash original demand	attached to component.			
Component	No visible mechanical damage	Insert 10cm wire into the remaining open			
Adhesion	,—\.\\\	eye bend ,the ends of even wire lengths			
(Pull test)	<b>%</b> -X	upward and wind together.			
	\$. \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	Terminal shall not be remarkably			
		damaged.			
Thermal shock	No visible mechanical damage	+110°C=>30±3min			
	2. Central Freq. change :within ±6%	-40°C=>30±3min			
		Test cycle:10 cycles			
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal			
	1 +110±5°C 30±3	condition for 2~3 hours before			
	2 Room Within	measuring.			
	Temperature 3sec	S .			
	3 -40±2°C 30±3				
	4 Room Within				
	Temperature 3sec				
Resistance to	1. No visible mechanical damage	Temperature: +110±5°C			
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs			
T					
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal			
Temperature	3. No disconnection or short circuit.	condition for 2~3 hours before			
		condition for 2~3 hours before measuring.			
Resistance to Low	No disconnection or short circuit.      No visible mechanical damage     Central Freq. change :within ±6%	condition for 2~3 hours before			
Resistance to	No visible mechanical damage	condition for 2~3 hours before measuring.  Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal			
Resistance to Low	No visible mechanical damage     Central Freq. change :within ±6%	condition for 2~3 hours before measuring.  Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before			
Resistance to Low Temperature	No visible mechanical damage     Central Freq. change :within ±6%     No disconnection or short circuit.	condition for 2~3 hours before measuring.  Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.			
Resistance to Low	No visible mechanical damage     Central Freq. change :within ±6%     No disconnection or short circuit.      No visible mechanical damage	condition for 2~3 hours before measuring.  Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.  Temperature: 40±2°C			
Resistance to Low Temperature	No visible mechanical damage     Central Freq. change :within ±6%     No disconnection or short circuit.      No visible mechanical damage     Central Freq. change :within ±6%	condition for 2~3 hours before measuring.  Temperature:-40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.  Temperature: 40±2°C Humidity: 90% to 95% RH			
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#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for reflow soldering in Figure 1.

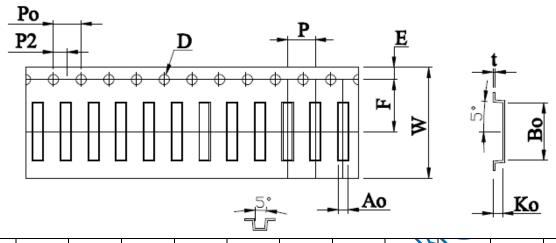
Products attachment with a soldering fron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- mm tip diameter (max)
- Limit soldering time to 3 sec.



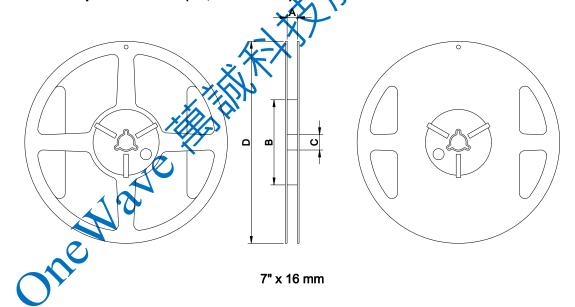
## **6.Packaging Information**

### **♦** Tape Specification:



W	Ao	Во	Ко	Р	F	E	D	D1		P2	t
16.0	1.30	8.30	1.40	4.00	7.50	1.75	1.50	0.00	4.00	2.00 ±0.10	0.30
±0.30	±0.10	±0.10	±0.10	±0.10	±0.10	±0.10	±0.10	±0.10	±0.10	±0.10	±0.05

♦ Reel Specification: (7", Φ180 mm)



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
16	16±1.0	60±2	13.5±0.5	178±2	3000



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- The packaging material should be kept where no chlorine or suffur exists in the air.

#### **Transportation Conditions**

The Wave Harith

- 1. Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.